

## STN2NF10

N-channel 100V - 0.23Ω - 2.4A - SOT-223 STripFET™ II Power MOSFET

#### **Features**

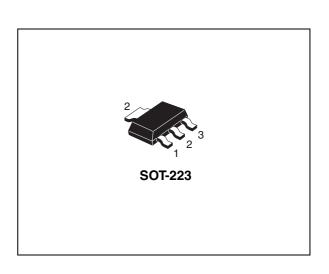
| Туре     | V <sub>DSS</sub> | R <sub>DS(on)</sub> | I <sub>D</sub> |
|----------|------------------|---------------------|----------------|
| STN2NF10 | 100V             | < 0.26Ω             | 2.4A           |

#### **Description**

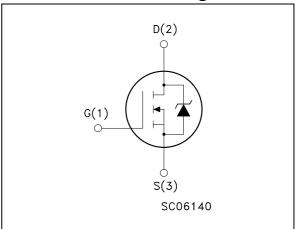
This Power MOSFET is the latest development of STMicroelectronics unique "single feature size" strip-based process. The resulting transistor shows extremely high packing density for low onresistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

### **Application**

- Switching application
  - DC-DC converters



#### Internal schematic diagram



#### Order code

| Part number | Marking | Package | Packaging   |  |
|-------------|---------|---------|-------------|--|
| STN2NF10    | N2NF10  | SOT-223 | Tape & reel |  |

Contents STN2NF10

## **Contents**

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STN2NF10 Electrical ratings

## 1 Electrical ratings

Table 1. Absolute maximum ratings

| Symbol                             | Parameter   | Value      | Unit |
|------------------------------------|---|------------|------|
| V <sub>DS</sub>                    | Drain-source voltage (V <sub>GS</sub> =0)             | 100        | V    |
| V <sub>GS</sub>                    | Gate-source voltage                                   | ± 20       | V    |
| I <sub>D</sub>                     | Drain current (continuous) at T <sub>C</sub> = 25°C   | 2.4        | Α    |
| I <sub>D</sub>                     | Drain current (continuous) at T <sub>C</sub> = 100°C  | 1.5        | Α    |
| I <sub>DM</sub> <sup>(1)</sup>     | Drain current (pulsed)                                | 17         | Α    |
|                                    | Derating factor                                       | 0.026      | W/°C |
| P <sub>TOT</sub> <sup>(2)</sup>    | Total dissipation at T <sub>C</sub> = 25°C            | 3.3        | W    |
| E <sub>AS</sub> (3)                | Single pulse avalanche energy                         | 200        | mJ   |
| dv/dt (4)                          | Peak diode recovery voltage slope                     | 30         | V/ns |
| T <sub>j</sub><br>T <sub>stg</sub> | Operating junction temperature<br>Storage temperature | -55 to 150 | °C   |

- 1. Pulse width limited by safe operating area
- 2. This value is rated according to Rthj-amb,  $t \le 10$ sec
- 3.  $I_{AS} = 2.4A$ ,  $V_{DD} = 30V$ ,  $Rg=4.7\Omega$ , starting Tj = 25°C
- 4.  $I_{SD} \le 6A$ ,  $di/dt \le 500A/\mu s$ ,  $V_{DD} = 80\% V_{(BR)DSS}$

Table 2. Thermal data

| Symbol                                       | Parameter                       | Value | Unit |
|--|---------------------------------|-------|------|
| Rthj-amb (1) Thermal resistance junction-amb |                                 | 38    | °C/W |
| Rthj-amb (2)                                 | Thermal resistance junction-amb | 62.5  | °C/W |

- 1. When mounted on 1inch² FR-4 board, 2 oz. Cu, (t < 10sec)
- 2. When mounted on 1inch $^2$  FR-4 board, 2 oz. Cu, (t >10sec)

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## 2 Electrical characteristics

(T<sub>CASE</sub>=25°C unless otherwise specified)

Table 3. On/off states

| Symbol               | Parameter Test conditions                             |   | Min. | Тур. | Max.         | Unit           |
|----------------------|---|---|------|------|--------------|----------------|
| V <sub>(BR)DSS</sub> | Drain-source breakdown voltage                        | $I_D = 250 \mu A, V_{GS} = 0$   | 100  |      |              | V              |
| I <sub>DSS</sub>     | Zero gate voltage drain current (V <sub>GS</sub> = 0) | $V_{DS}$ = Max rating,<br>$V_{DS}$ = Max rating, Tc=125°C<br>$V_{DS}$ = 30V, Tc=125°C |      |      | 1<br>10<br>1 | μΑ<br>μΑ<br>μΑ |
| I <sub>GSS</sub>     | Gate body leakage current (V <sub>DS</sub> = 0)       | V <sub>GS</sub> = ±20V  |      |      | ±100         | nA             |
| V <sub>GS(th)</sub>  | Gate threshold voltage                                | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$  | 2    |      | 4            | ٧              |
| R <sub>DS(on)</sub>  | Static drain-source on resistance                     | V <sub>GS</sub> = 10V, I <sub>D</sub> = 1.2A  |      | 0.23 | 0.26         | Ω              |

Table 4. Dynamic

| Symbol   | Parameter   | Test conditions   | Min. | Тур.            | Max. | Unit           |
|--|---|---|------|-----------------|------|----------------|
| 9 <sub>fs</sub>  | Forward transconductance  | V <sub>DS</sub> =15V, I <sub>D</sub> =1.2A                      |      | 2.5             |      | S              |
| C <sub>iss</sub><br>C <sub>oss</sub><br>C <sub>rss</sub> | Input capacitance Output capacitance Reverse transfer capacitance | V <sub>DS</sub> =25V, f=1MHz, V <sub>GS</sub> =0                |      | 280<br>45<br>20 |      | pF<br>pF<br>pF |
| $egin{array}{c} Q_{ m g} \ Q_{ m gd} \end{array}$        | Total gate charge<br>Gate-source charge<br>Gate-drain charge      | $V_{DD}$ =80V, $I_{D}$ = 6A<br>$V_{GS}$ =10V<br>(see Figure 15) |      | 10<br>2.5<br>4  | 14   | nC<br>nC<br>nC |

Table 5. Switching times

| Symbol              | Parameter                        | Test conditions  | Min. | Тур.    | Max. | Unit     |
|---------------------|----------------------------------|--|------|---------|------|----------|
| t <sub>d(on)</sub>  | Turn-on delay time<br>Rise time  | $V_{DD}$ =50V, $I_D$ = 2.4A<br>$V_{GS}$ =10V, $R_G$ =4.7 $\Omega$<br>(see Figure 14)     |      | 6<br>10 |      | ns<br>ns |
| t <sub>d(off)</sub> | Turn-off delay time<br>Fall time | $V_{DD}$ =50V, $I_{D}$ = 2.4A<br>$V_{GS}$ =10V, $R_{G}$ =4.7 $\Omega$<br>(see Figure 14) |      | 20<br>3 |      | ns<br>ns |

Table 6. Source drain diode

| Symbol   | Parameter  | Test conditions   | Min. | Тур.           | Max       | Unit          |
|--|--|---|------|----------------|-----------|---------------|
| I <sub>SD</sub>  | Source-drain current Source-drain current (pulsed)                     |   |      |                | 2.4<br>17 | A<br>A        |
| V <sub>SD</sub> <sup>(2)</sup>                         | Forward on voltage   | I <sub>SD</sub> = 2.4A, V <sub>GS</sub> =0  |      |                | 1.2       | V             |
| t <sub>rr</sub><br>Q <sub>rr</sub><br>I <sub>RRM</sub> | Reverse recovery time Reverse recovery charge Reverse recovery current | I <sub>SD</sub> = 6A, V <sub>DD</sub> =10V<br>di/dt=100A/μs,Tj=150°C<br>(see Figure 19) |      | 70<br>175<br>5 |           | ns<br>nC<br>A |

<sup>1.</sup> Pulse width limited by safe operating area

<sup>2.</sup> Pulsed: pulse duration = 300µs, duty cycle 1.5%

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### 2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

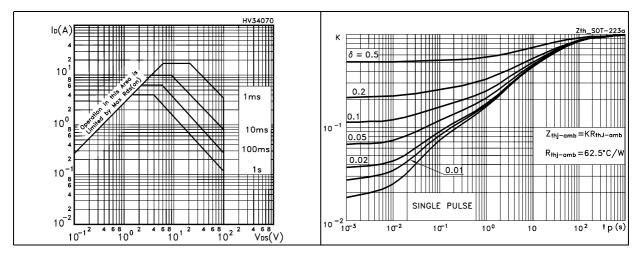


Figure 3. Output characteristics

Figure 4. Transfer characteristics

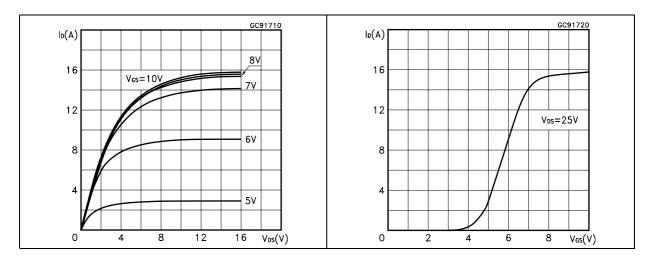
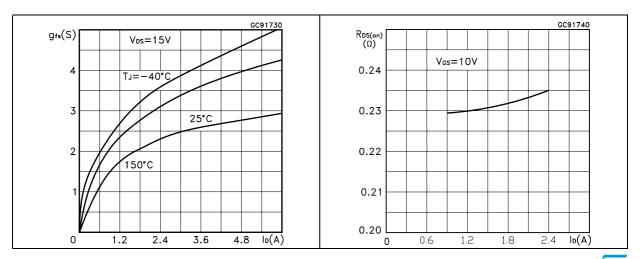


Figure 5. Transconductance

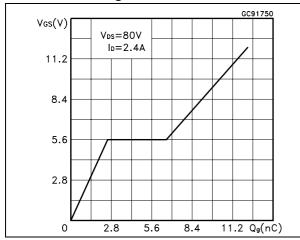
Figure 6. Static drain-source on resistance



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Figure 7. Gate charge vs. gate-source voltage

Figure 8. Capacitance variations



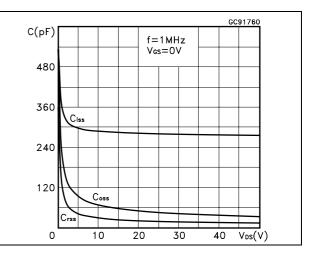
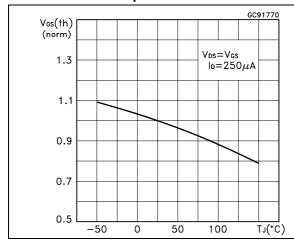


Figure 9. Normalized gate threshold voltage Figure 10. vs. temperature

Figure 10. Normalized on resistance vs. temperature



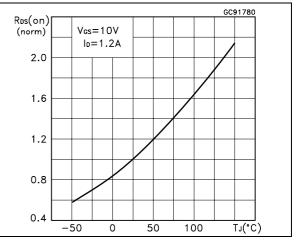
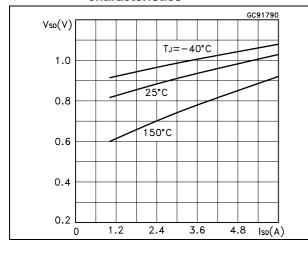
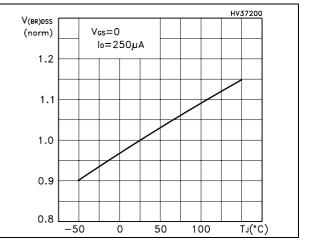


Figure 11. Source-drain diode forward characteristics

Figure 12. Normalized  $\mathrm{BV}_\mathrm{DSS}$  vs. temperature

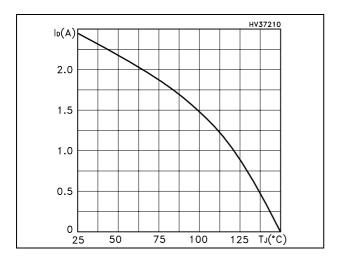




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Figure 13. Max drain current vs. temperature



STN2NF10 Test circuit

### 3 Test circuit

Figure 14. Switching times test circuit for resistive load

Figure 15. Gate charge test circuit

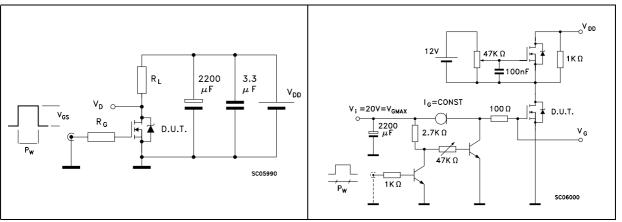


Figure 16. Test circuit for inductive load switching and diode recovery times

Figure 17. Unclamped inductive load test circuit

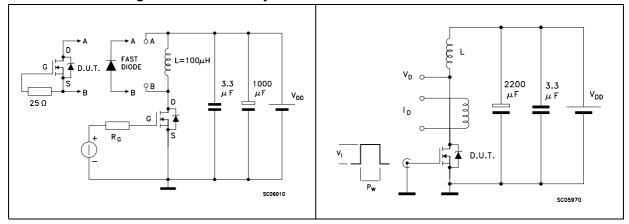
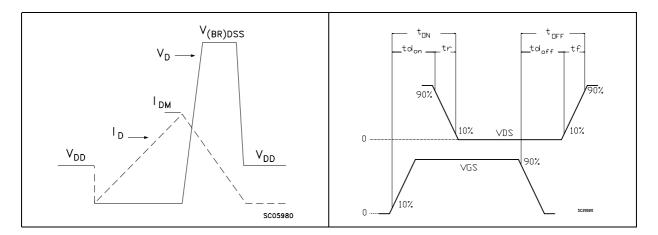


Figure 18. Unclamped inductive waveform

Figure 19. Switching time waveform



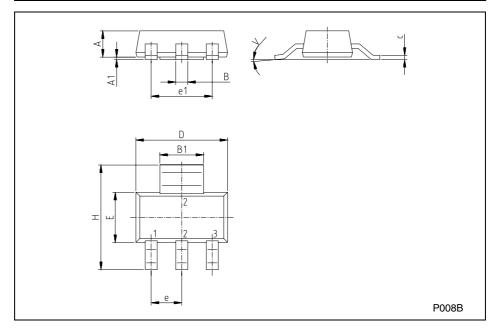
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## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: <a href="https://www.st.com">www.st.com</a>

#### **SOT-223 MECHANICAL DATA**

| DIM.  |      | mm   |      |       | inch  |       |
|-------|------|------|------|-------|-------|-------|
| Dini. | MIN. | TYP. | MAX. | MIN.  | TYP.  | MAX.  |
| Α     |      |      | 1.80 |       |       | 0.071 |
| В     | 0.60 | 0.70 | 0.80 | 0.024 | 0.027 | 0.031 |
| B1    | 2.90 | 3.00 | 3.10 | 0.114 | 0.118 | 0.122 |
| С     | 0.24 | 0.26 | 0.32 | 0.009 | 0.010 | 0.013 |
| D     | 6.30 | 6.50 | 6.70 | 0.248 | 0.256 | 0.264 |
| е     |      | 2.30 |      |       | 0.090 |       |
| e1    |      | 4.60 |      |       | 0.181 |       |
| E     | 3.30 | 3.50 | 3.70 | 0.130 | 0.138 | 0.146 |
| Н     | 6.70 | 7.00 | 7.30 | 0.264 | 0.276 | 0.287 |
| V     |      |      | 10°  |       |       | 10°   |
| A1    |      | 0.02 |      |       |       |       |



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Revision history STN2NF10

# 5 Revision history

Table 7. Revision history

| Date        | Revision | Changes   |
|-------------|----------|---|
| 14-Sep-2006 | 4        | The document has been reformatted                         |
| 29-Mar-2007 | 5        | Figure 1 has been updated                                 |
| 04-Apr-2007 | 6        | New test condition for I <sub>DSS</sub> on <i>Table 3</i> |

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